Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | OIKAWA ET AL. | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|---|-----------------|------------------|----------------|
| * | Α | US-5,147,732 A | 09-1992 | Shiroishi et al. | 428/668 |
| * | В | US-5,965,248 A | 10-1999 | Saitoh et al. | 428/842.3 |
| * | С | US-2004/0184176 A1 | 09-2004 | Shimazaki et al. | 360/059 |
| * | D | US-2004/0219329 A1 | 11-2004 | Oikawa et al. | 428/065.3 |
| * | E | US-2005/0249984 A1 | 11-2005 | Ohmori et al. | 428/846.1 |
| * | F | US-2006/0098357 A1 | 05-2006 | Hasegawa et al. | 360/324.11 |
| | G | US- | | | |
| | Н | US- | | | |
| | 1 | US- | | | |
| | j | US- | | | |
| | К | US- | | | |
| | L | US- | | | |
| | М | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | 0 | | | | | |
| | Р | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | S | | | | | · |
| | Т | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | υ | |
| | v | |
| | w | |
| | x | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.